

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Kazunobu MIKI

Serial No.:

Filed: October 10, 2001

For: SEMICONDUCTOR ELEMENT TEST APPARATUS, AND METHOD OF TESTING
SEMICONDUCTOR ELEMENT USING THE APPARATUS

Group Art Unit:

Examiner:

*a / Prel. amdt.
A
E. Willis
3-18-02*PRELIMINARY AMENDMENTCommissioner for Patents
Washington, DC 20231

Sir:

Prior to examination of the above-referenced application, please amend the application as

follows:

IN THE DRAWINGS:

On Page 8 in the "Brief Description of the Drawings", please add the following:


--Fig. 19A and 19B are typical views showing a round-head screw.--

REMARKS

The above application is amended to include Figures 19A and 19B in the "Brief Description of the Drawings". Attached hereto is a clean copy of page 8 as amended. Entry of this preliminary amendment is respectfully requested.

Respectfully submitted,

MCDERMOTT, WILL & EMERY



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